# AI DIGITAL DATA TRANSMISSION SYSTEM WORD GENERATOR CIRCUIT SD-1G005-01 OUT-OF-SERVICE TESTS 

## 1. GENERAL

1.01 This section describes a method of making out-of-service tests on the word generator in A1 digital data signaling systems.
1.02 This section is reissued to revise the title of the section to include identifying schematic SD-1G005-01, to make minor changes, and to incorporate adjustment procedures for the matching and error circuit SD-1G006-01 used in Test C. Since this reissue covers a general revision, arrows ordinarily used to indicate changes have been omitted.
1.03 The tests covered are:
A. Adjustments: This test checks that the timing slicer adjustment is proper to insure operation of the binary counters, the start pulse slicer and data slicer are adjusted, the word length is adjustable by means of S14 switch to 256 bit words, and a double-start pulse can be generated.
B. Dipulse Output: This test checks that the ratio potentiometer is adjusted to produce equal amplitude data pulses and timing wave, each data switch produces an appropriate dipulse, the output level is the proper value, and the TMG potentiometer is correctly adjusted to obtain the best possible wave shape of data dipulses.
C. Synchronization: This test checks that the word generator can be synchronized to another data source and shall only be applied in locations where two word generators are used; one in conjunction with the matching and error counter circuit, SD-1G006-01.
1.04 Section 314-505-302 covers the analysis and clearance of trouble for this section.
1.05 Lettered Steps: A letter a, b, c, etc added to a step number in Parts 3 or 4 of this section, indicates an action which may or may not be required, depending on local conditions. The condition under which a lettered step or a series of lettered steps should be made is given in the ACTION column, and all steps governed by the same condition are designated by the same letter within a test. Where a condition does not apply, all steps designated by that letter should be omitted.

## 2. APPARATUS

2.01 Hewlett-Packard 400C voltmeter (VTVM) or equivalent.
2.02 Oscilloscope, KS-16305, L1 equipped with Waterman Company direct-attenuator probe DFI-029-A01 and attenuator probe DFI-027-A01.
2.03 Volt-ohm-milliammeter, KS-14510, L1 or equivalent.
2.04 Jack and connector circuit, SD-1G008-01.
2.05 One 262B plug ( 600 ohm ).
2.06 Three patching cords, P3E cord, 4 feet long, equipped with two 310 plugs (3P7E cord).
2.07 Patching cord, 3 feet long, equipped with two Grip-Rite plugs and one 310 plug (P2CL cord).
2.08 Matching and error counter circuit, SD-1G006-01.

## 3. PREPARATION

## STEP

ACTION

All Tests
1 Arrange word generator under test as word gen. 1, block diagram, Fig. 101, SD-1G008-01, Issue 3 or higher, jack and connector circuit.

2 Set volt-ohm-milliammeter switch to 300 volts dc.

3 Connect negative lead of volt-ohm-milliammeter to GRD test point of either DDT or DDR in test fixture.

Connect positive lead of volt-ohm-milliammeter to word generator +130 V test point.

5 Disconnect volt-ohm-milliammeter leads.
6 Set volt-ohm-milliammeter switch to 60 volts dc.

7 Connect positive lead of volt-ohm-milliammeter to word generator $\mathrm{F}+$ test point.

8 Connect negative lead of volt-ohm-milliammeter to word generator -48 V test point.

9a If requirement of Step 8 is not met Adjust FIL potentiometer for 40 -volt indication.
4. METHOD

## A. Adjustments

11 Prepare KS-16305 oscilloscope per Section 100-658-100, Preliminary Installation and Adjustments, setting V INPUT SELECTOR to PANEL.

12 Connect oscilloscope SYNC input into word generator SYNC test point (DFI-029-A01 cord).

13 Set oscilloscope H-SEL to LIN SWEEP and SYNC SEL to REP-INT-HI.

Adjust oscilloscope SYNC control.
Set V MULT switch of oscilloscope to CAL, adjust CAL potentiometer to obtain reading on oscilloscope voltmeter of 0.2 volt peak to peak.

Adjust oscilloscope V GAIN control to obtain 1-inch peak-to-peak deflection.

Set V MULT switch of oscilloscope to 10, Y INPUT SELECTOR to PANEL.

Set oscilloscope probe on DFI-027-A01 cord to $10: 1$, connect cord to V-INP-AC jack.

Insert probe into word generator BCA1 test point, adjust TMG potentiometer if necessary.

Set SYNC SEL switch of oscilloscope to TRIG EXT HI, adjust SWEEP.

Remove probe, insert it into word generator ST test point.

Adjust ST-SL potentiometer if necessary.

Remove probe from ST test point, insert it into word generator DAT test point.

Operate S 2 switch to ON position, assure that S1, S3 through S13 switches are OFF, adjust DAT-SL potentiometer if necessary.

Remove probe, insert it into ST test point, set S14 switch to position 16.

Adjust sweep on oscilloscope.
Operate S14 switch to position 32.
Adjust oscilloscope sweep.
Operate S14 switch to position 64.
Remove oscilloscope SYNC input connection from SYNC test point, insert it in word generator DS test point.

## VERIFICATION

Trace appears on oscilloscope.
Oscilloscope voltmeter indicates 0.2 volt.

Oscilloscope displays 1-inch peak-to-peak deflection.

Oscilloscope displays 10 -volt peak-to-peak square wave.

Oscilloscope displays positive-going square pulse of 2 -inch width.

Oscilloscope displays rectangular pulse of 2 -inch width.

Oscilloscope displays rectangular pulse of 2 -inch width.

Oscilloscope displays four pulses.
Oscilloscope displays two pulses.
Oscilloscope displays four pulses.
Oscilloscope displays two pulses.

ACTION

Adjust oscilloscope sweep.

Operate S14 switch to position 128.
Operate S14 switch to position 256.

Operate, release S15 switch.

Set S14 switch to position 16.

## VERIFICATION

Oscilloscope displays four pulses.
Oscilloscope displays two pulses.
Oscilloscope displays one pulse.
Pulse width doubles while S15 switch is operated.

## B. Dipulse Output

Prepare KS-16305 oscilloscope per Section 100-658-100, Preliminary Installation and Adjustments, setting V INPUT SELECTOR to PANEL.

Set S14 switch to position 16 , S1 through S13, S15 switches to OFF position.

Connect word generator SYNC test point to oscilloscope SYNC input using DFI-029-A01 cord.

Set V MULT switch of oscilloscope to CAL, adjust CAL potentiometer to obtain reading on oscilloscope voltmeter of 0.1 volt peak to peak.

Adjust oscilloscope V GAIN control to obtain 1 -inch peak-to-peak deflection.

Connect oscilloscope probe to V-INP-AC jack of oscilloscope (DFI-027-A01 cord).

Insert oscilloscope probe into word generator ST test point, adjust sweep of oscilloscope.

Remove oscilloscope probe.
Patch W-GEN-1 ST or S jack of jack and connector circuit to one of MULT TST jacks (P3E cord).

Insert a 262 B plug into another MULT TST jack, patch third MULT TST jack to V2 jack (P3E cord).

Note: Keep start data and timing IN jacks and connector circuit terminated in 600 ohms for remainder of test.

Oscilloscope indicates 0.1 volt peak to peak.

Oscilloscope displays 1-inch peak-to-peak deflection.

One start pulse displayed on oscilloscope.

27c If verification of Step 26 is not met -
Adjust DAT-SL potentiometer until one dipulse appears, corresponding to each operated switch.
Set oscilloscope V INPUT SELECTOR to BAL AC and V MULT switch to 10, adjust word generator LEVEL potentiometer.

Remove cord from W-GEN-1 ST or S jack, connect to W-GEN-1 DAT or D jack.

Operate in succession S1, S3, S5, S7, S9, S11, S13 switches to ON position.

If verification of Step 23 is not met -
Adjust DAT-SL potentiometer until one dipulse appears, corresponding to each operated switch.

After verification of Step 23, restore all data switches to OFF position.

Operate in succession $\mathrm{S} 2, \mathrm{~S} 4, \mathrm{~S} 6, \mathrm{~S} 8, \mathrm{~S} 10$, S12 switches to ON position.

Operate all data switches to OFF position.
Operate S1 through S13 switches to ON position.

If verification of Step 29 is not met Adjust DAT-SL potentiometer until one dipulse appears, corresponding to each operated switch, then repeat Steps 23 through 29.

After verification of Step 29, remove cord from W-GEN-1 DAT or D jack and insert it into W-GEN-1 ST or S jack.

Operate S1 through S13 switches to ON position.

Operate S1, S3, S4, S5, S9, S10, S11, S13 switches to OFF position.

Remove cord from W-GEN-1 ST or S jack, insert it into W-GEN-1 T jack, adjust word generator RATIO potentiometer.

Remove cord from W-GEN-1 T jack, insert it into W-GEN-1 DAT or D jack.

## VERIFICATION

Start dipulse displayed on oscilloscope with 1/2-inch peak-to-peak deflection.

No dipulses displayed on oscilloscope.

One dipulse displayed corresponding to each operated switch.

No dipulses displayed.

One dipulse displayed corresponding to each operated switch.

One dipulse displayed corresponding to each operated switch.

Start dipulse of $1 / 2$-inch peak-to-peak amplitude displayed on oscilloscope.

No change in oscilloscope pattern.

Sine wave of $1 / 2$-inch peak-to-peak amplitude displayed on oscilloscope.

Data dipulses displayed on oscilloscope.

## ACTION

Adjust word generator TMG potentiometer. Remove cord connecting V2 jack, MULT TST jack.

Patch VTVM to MULT TST jack, adjust LEVEL potentiometer (P2CL cord).

If requirement of Step 38 is not met Adjust LEVEL potentiometer to obtain reading of -12 db .

Remove all cord connections.

## C. Synchronization

Arrange another word generator as word gen. 2, block diagram, Fig. 101, SD-1G008, Issue 3, or higher, jack and connector circuit.

At matching and error circuit SD-1G006-01 Set voltmeter switch to 60 -volt scale.

Connect positive lead of volt-ohm-milliammeter to $\mathrm{F}+$ test point.

Connect negative lead of volt-ohm-milliammeter to -48 V test point.

Adjust FIL potentiometer for reading of 40 volts.

Disconnect volt-ohm-milliammeter leads.
Using DFI-027-A01 cord, connect oscilloscope probe to DP test point.

Adjust DP potentiometer for proper pulse amplitude.

Remove probe, insert it into WG test point.
Adjust WG potentiometer for proper amplitude.

Remove probe, insert it into TMG test point.
At word gen. 1 -
Operate SW2 switch to ON.
At matching and error circuit -
Insure WG switch is OFF.
$30 \mathrm{c} \quad$ If requirement of Step 29 is not met Adjust word gen. 1 LEVEL potentiometer to obtain 0 db reading.

31 Operate switches $\mathrm{S} 2, \mathrm{~S} 6, \mathrm{~S} 7, \mathrm{~S} 8$ of both word generators to $O N$ position, all other S- switches to OFF position.
Adjust TMG potentiometer to center spike.

If a phase reversal is displayed Operate PHASE switch to opposite position.

Adjust PHASE potentiometer for proper spike amplitude.

Insert 262B plug into one of the MULT TST jacks on jack and connector circuit.

Patch from W-GEN-1 T jack to a second of the MULT TST jacks on jack and connector circuits (P3E cord).

Patch VTVM to third MULT TST jack (P2CL cord).

Remove 310 plug from MULT TST jack, insert in M CKT T jack on jack and connector circuit (P3E cord).

Patch W-GEN-1 DAT or D, ST or S jacks to M CKT DAT or D, ST or S jacks, respectively (two P3E cords).

Operate S3 switch of word gen. 1 to ON position.

Operate S3 switch of word gen. 2 to ON position.

Remove 310 plug from M CKT T jack, insert into MULT TST jack (P3E cord).

If requirement of Step 36 is not met Adjust LEVEL potentiometer of word generator for -12 db .

Remove all patching cords and plugs.

## VERIFICATION

Oscilloscope displays spike portion of waveform centered between two notches on pedestal.

Oscilloscope displays positive portion of spike with $25 \pm 5$ volt peak-to-peak amplitude.

VTVM indicates 0 db .

Matching circuit counter counts steadily.

Matching circuit counter ceases to count.

VTVM indicates -12 db .

